

PDTC143/114/124/144EQA Series 50 V, 100 mA NPN resistor-equipped transistors

Rev. 1 — 30 October 2015

Product data sheet

Product profile

1.1 General description

100 mA NPN Resistor-Equipped Transistor (RET) family in a leadless ultra small DFN1010D-3 (SOT1215) Surface-Mounted Device (SMD) plastic package with visible and solderable side pads.

Table 1. **Product overview**

Type number	R1	R2	Package NXP	PNP complement
PDTC143EQA	4.7 kΩ	4.7 kΩ		PDTA143EQA
PDTC114EQA	10 kΩ	10 kΩ	(SOT1215)	PDTA114EQA
PDTC124EQA	22 kΩ	22 kΩ		PDTA124EQA
PDTC144EQA	47 kΩ	47 kΩ	-	PDTA144EQA

1.2 Features and benefits

- 100 mA output current capability
- Built-in bias resistors
- Simplifies circuit design
- Reduces component count
- Reduced pick and place costs
- Low package height of 0.37 mm
- AEC-Q101 qualified
- Suitable for Automatic Optical Inspection (AOI) of solder joint

1.3 Applications

- Digital applications
- Cost saving alternative for BC847/BC857 series in digital applications
- Controlling IC inputs
- Switching loads

1.4 Quick reference data

Table 2. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	50	V
Io	output current		-	-	100	mA



2. Pinning information

Table 3. Pinning

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	I	input (base)		
2	GND	GND (emitter)		
3	0	output (collector)		I R1
4	Ο	output (collector)	2 4 3 Transparent top view	GND

3. Ordering information

Table 4. Ordering information

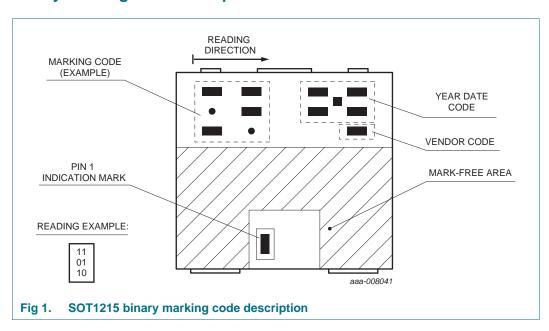
Type number	Package		
	Name	Description	Version
PDTC143EQA	DFN1010D-3	plastic thermal enhanced ultra thin small outline	SOT1215
PDTC114EQA		package; no leads; 3 terminals; body: 1.1 × 1.0 × 0.37 mm	
PDTC124EQA		body. 1.1 × 1.0 × 0.37 IIIII	
PDTC144EQA			

4. Marking

Table 5. Marking codes

Type number	Marking code
PDTC143EQA	10 10 01
PDTC114EQA	11 01 10
PDTC124EQA	10 11 01
PDTC144EQA	10 01 10

4.1 Binary marking code description



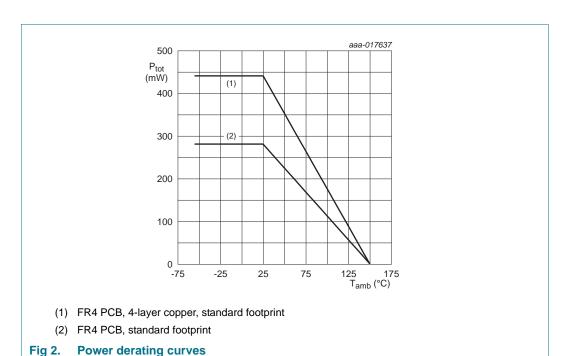
5. Limiting values

Table 6. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	50	V
V _{CEO}	collector-emitter voltage	open base	-	50	V
V_{EBO}	emitter-base voltage		-	10	V
VI	input voltage				'
	PDTC143EQA		-10	+30	V
	PDTC114EQA		-10	+40	V
	PDTC124EQA		-10	+40	V V V
	PDTC144EQA		-10	+40	
Io	output current		-	100	mA
P _{tot}	total power dissipation	T _{amb} ≤ 25 °C	[1] -	280	mW
			[2] _	440	mW
Tj	junction temperature		-	150	°C
T _{amb}	ambient temperature		-55	+150	°C
T _{stg}	storage temperature		-65	+150	°C

- [1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, 4-layer copper, tin-plated and standard footprint.

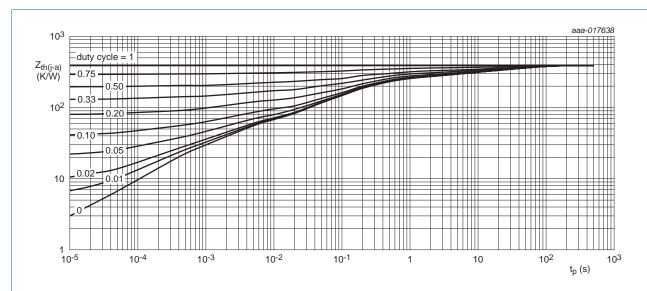


6. Thermal characteristics

Table 7. Thermal characteristics

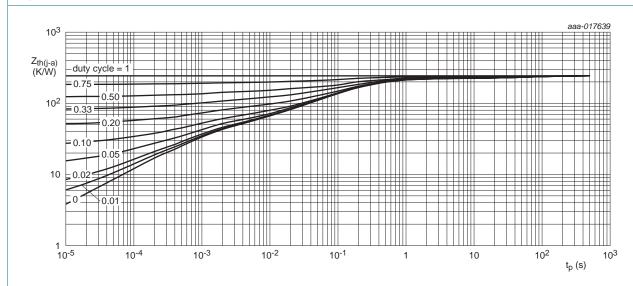
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
ιι () α)		in free air	1 -	-	446	K/W
	to ambient	<u></u>	2] -	-	284	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, 4-layer copper, tin-plated and standard footprint.



FR4 PCB, single-sided copper, tin-plated and standard footprint

Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



FR4 PCB, 4-layer copper, tin-plated and standard footprint.

Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

PDTC143_114_124_144EQA_SER

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7. Characteristics

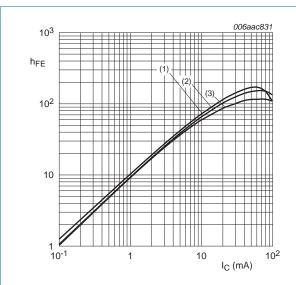
Table 8. Characteristics

 $T_{amb} = 25$ °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off current	$V_{CB} = 50 \text{ V}; I_E = 0 \text{ A}$	-	-	100	nA
I _{CEO}	collector-emitter cut-off	V _{CE} = 30 V; I _B = 0 A	-	-	1	μА
	current	V _{CE} = 30 V; I _B = 0 A; T _j = 150 °C	-	-	5	μΑ
I _{EBO}	emitter-base cut-off curr	ent				
	PDTC143EQA	V _{EB} = 5 V; I _C = 0 A	-	-	900	μА
	PDTC114EQA		-	-	400	μΑ
	PDTC124EQA		-	-	180	μΑ
	PDTC144EQA		-	-	90	μΑ
h _{FE}	DC current gain				'	
	PDTC143EQA	$V_{CE} = 5 \text{ V; } I_{C} = 10 \text{ mA}$	30	-	-	
	PDTC114EQA	V _{CE} = 5 V; I _C = 5 mA	30	-	-	
	PDTC124EQA		60	-	-	
	PDTC144EQA		80	-	-	
V _{CEsat}	collector-emitter saturation voltage	$I_C = 10 \text{ mA}; I_B = 0.5 \text{ mA}$	-	-	150	mV
V _{I(off)}	off-state input voltage					
	PDTC143EQA	$V_{CE} = 5 \text{ V; } I_{C} = 100 \mu\text{A}$	-	1.1	0.5	V
	PDTC114EQA		-	1.1	0.8	V
	PDTC124EQA		-	1.1	0.8	V
	PDTC144EQA		-	1.2	0.8	V
V _{I(on)}	on-state input voltage					
	PDTC143EQA	$V_{CE} = 0.3 \text{ V; } I_{C} = 20 \text{ mA}$	2.5	1.9	-	V
	PDTC114EQA	V _{CE} = 0.3 V; I _C = 10 mA	2.5	1.8	-	V
	PDTC124EQA	$V_{CE} = 0.3 \text{ V; } I_{C} = 5 \text{ mA}$	2.5	1.7	-	V
	PDTC144EQA	$V_{CE} = 0.3 \text{ V}; I_{C} = 2 \text{ mA}$	3	1.6	-	V
R1	bias resistor 1 (input)	[1]				
	PDTC143EQA		3.3	4.7	6.1	kΩ
	PDTC114EQA		7	10	13	kΩ
	PDTC124EQA		15.4	22	28.6	kΩ
	PDTC144EQA		33	47	61	kΩ
R2/R1	bias resistor ratio	[1]	0.8	1	1.2	
C _c	collector capacitance	V _{CB} = 10 V; I _E = i _e = 0 A; f = 1 MHz	-	-	2.5	pF
f _T	transition frequency	$V_{CE} = 5 \text{ V; } I_{C} = 10 \text{ mA; } f = 100 \text{ MHz}$	-	230	-	MHz

^[1] See Section 8 "Test information" for resistor calculation and test conditions.

^[2] Characteristics of built-in transistor.



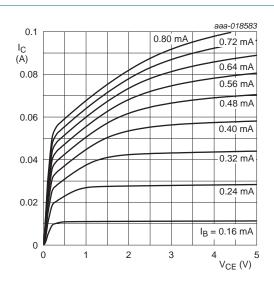
 $V_{CE} = 5 V$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

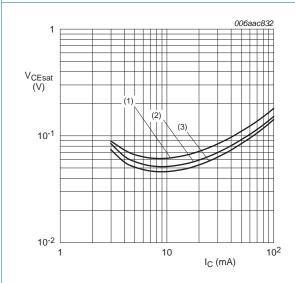
(3) $T_{amb} = -40 \, ^{\circ}C$





T_{amb} = 25 °C

Fig 6. PDTC143EQA: Collector current as a function of collector-emitter voltage; typical values



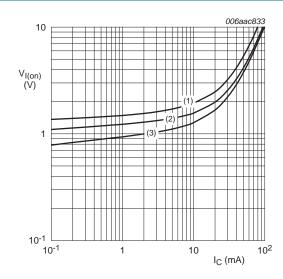
 $I_{\rm C}/I_{\rm B} = 20$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3) $T_{amb} = -40 \, ^{\circ}C$

Fig 7. PDTC143EQA: Collector-emitter saturation voltage as a function of collector current; typical values



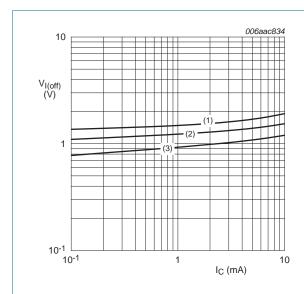
 $V_{CE} = 0.3 \text{ V}$

(1)
$$T_{amb} = -40 \, ^{\circ}C$$

(2) $T_{amb} = 25 \, ^{\circ}C$

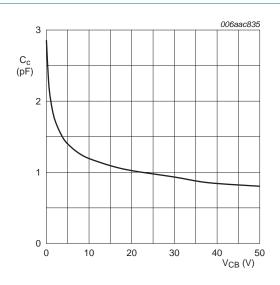
(3) $T_{amb} = 100 \, ^{\circ}C$

Fig 8. PDTC143EQA: On-state input voltage as a function of collector current; typical values



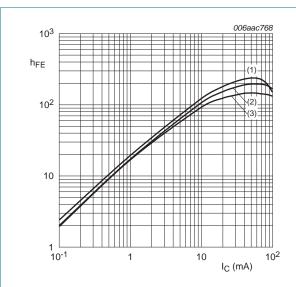
- $V_{CE} = 5 V$
- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 9. PDTC143EQA: Off-state input voltage as a function of collector current; typical values



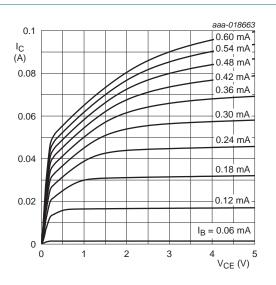
 $f = 1 \text{ MHz}; T_{amb} = 25 \,^{\circ}\text{C}$

Fig 10. PDTC143EQA: Collector capacitance as a function of collector-base voltage; typical values



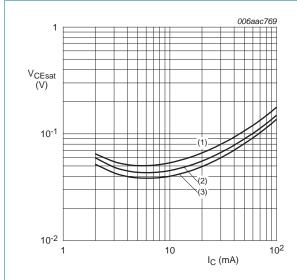
- $V_{CE} = 5 V$
- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -40 \, ^{\circ}C$

Fig 11. PDTC114EQA: DC current gain as a function of collector current; typical values



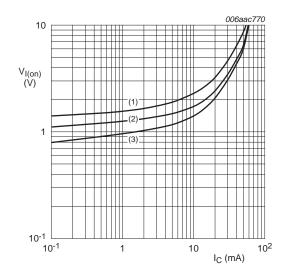
T_{amb} = 25 °C

Fig 12. PDTC114EQA: Collector current as a function of collector-emitter voltage; typical values



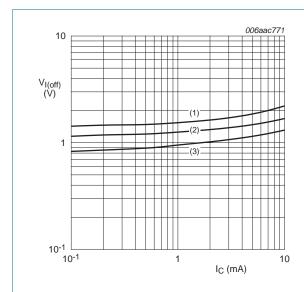
- $I_{\rm C}/I_{\rm B} = 20$
- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -40 \, ^{\circ}C$

Fig 13. PDTC114EQA: Collector-emitter saturation voltage as a function of collector current; typical values



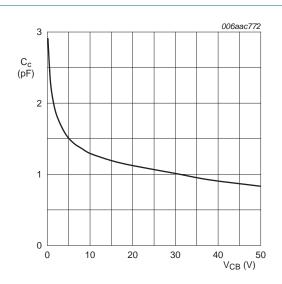
- $V_{CE} = 0.3 \text{ V}$
- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 14. PDTC114EQA: On-state input voltage as a function of collector current; typical values



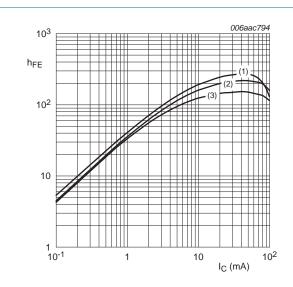
- $V_{CE} = 5 V$
- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 15. PDTC114EQA: Off-state input voltage as a function of collector current; typical values



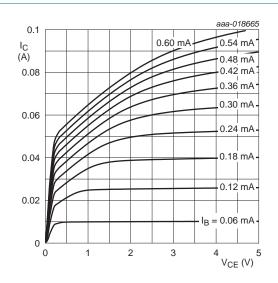
 $f = 1 \text{ MHz}; T_{amb} = 25 \,^{\circ}\text{C}$

Fig 16. PDTC114EQA: Collector capacitance as a function of collector-base voltage; typical values



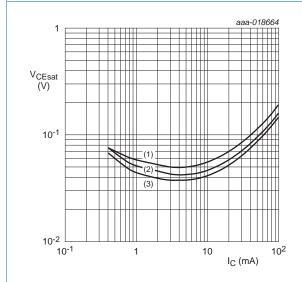
- $V_{CE} = 5 V$
- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -40 \, ^{\circ}C$

Fig 17. PDTC124EQA: DC current gain as a function of collector current; typical values



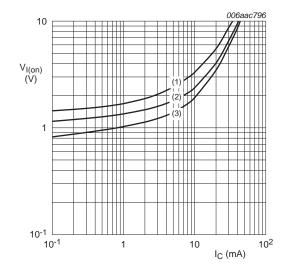
T_{amb} = 25 °C

Fig 18. PDTC124EQA: Collector current as a function of collector-emitter voltage; typical values



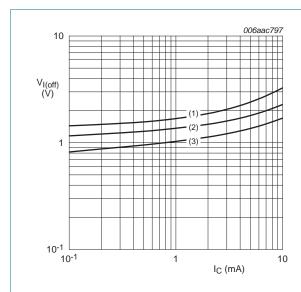
- $I_{\rm C}/I_{\rm B} = 20$
- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -40 \, ^{\circ}C$

Fig 19. PDTC124EQA: Collector-emitter saturation voltage as a function of collector current; typical values



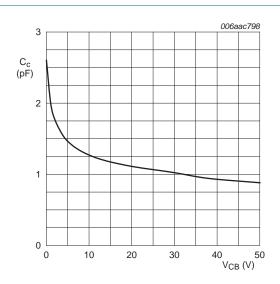
- $V_{CE} = 0.3 V$
- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 20. PDTC124EQA: On-state input voltage as a function of collector current; typical values



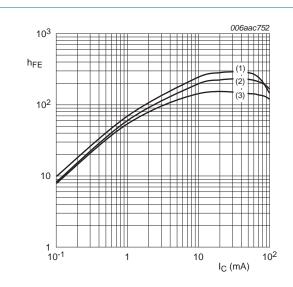
- $V_{CE} = 5 V$
- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 21. PDTC124EQA: Off-state input voltage as a function of collector current; typical values



 $f = 1 \text{ MHz}; T_{amb} = 25 \text{ }^{\circ}\text{C}$

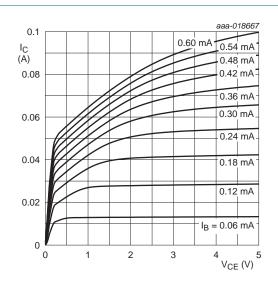
Fig 22. PDTC124EQA: Collector capacitance as a function of collector-base voltage; typical values



 $V_{CE} = 5 V$

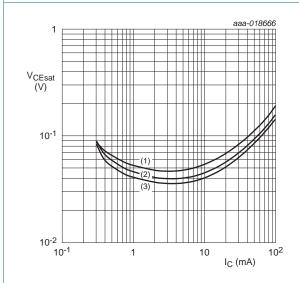
- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -40 \, ^{\circ}C$

Fig 23. PDTC144EQA: DC current gain as a function of collector current; typical values



T_{amb} = 25 °C

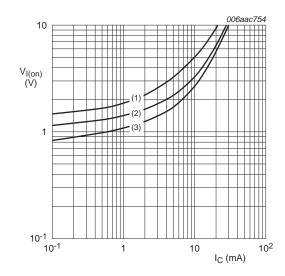
Fig 24. PDTC144EQA: Collector current as a function of collector-emitter voltage; typical values



 $I_{\rm C}/I_{\rm B} = 20$

- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -40 \, ^{\circ}C$

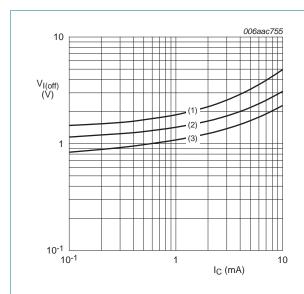
Fig 25. PDTC144EQA: Collector-emitter saturation voltage as a function of collector current; typical values



 $V_{CE} = 0.3 \text{ V}$

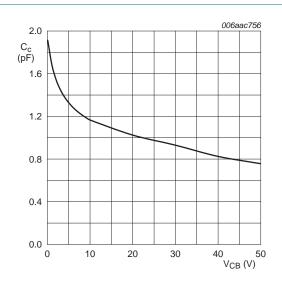
- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 26. PDTC144EQA: On-state input voltage as a function of collector current; typical values



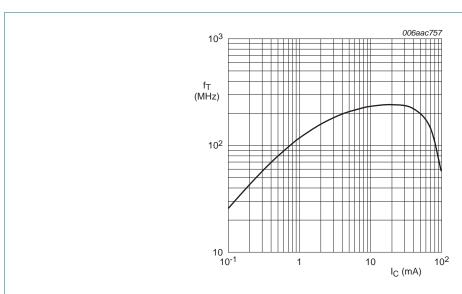
- $V_{CE} = 5 V$
- (1) $T_{amb} = -40 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 27. PDTC144EQA: Off-state input voltage as a function of collector current; typical values



 $f = 1 \text{ MHz}; T_{amb} = 25 \text{ }^{\circ}\text{C}$

Fig 28. PDTC144EQA: Collector capacitance as a function of collector-base voltage; typical values



 $V_{CE} = 5 \text{ V}; T_{amb} = 25 ^{\circ}\text{C}$

Fig 29. Transition frequency as a function of collector current; typical values of built-in transistor

8. Test information

8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101 - Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

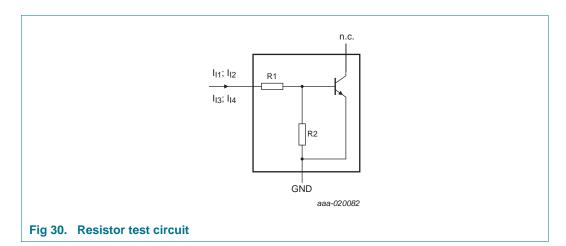
8.2 Resistor calculation

• Calculation of bias resistor 1 (R1):

$$R1 = \frac{V(I_{I2}) - V(I_{I1})}{I_{I2} - I_{I1}}$$

• Calculation of bias resistor ratio (R2/R1):

$$\frac{R2}{RI} = \frac{V(I_{I4}) - V(I_{I3})}{RI \cdot (I_{I4} - I_{I3})} - 1$$

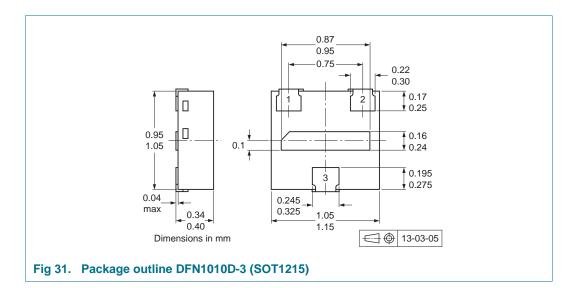


8.3 Resistor test conditions

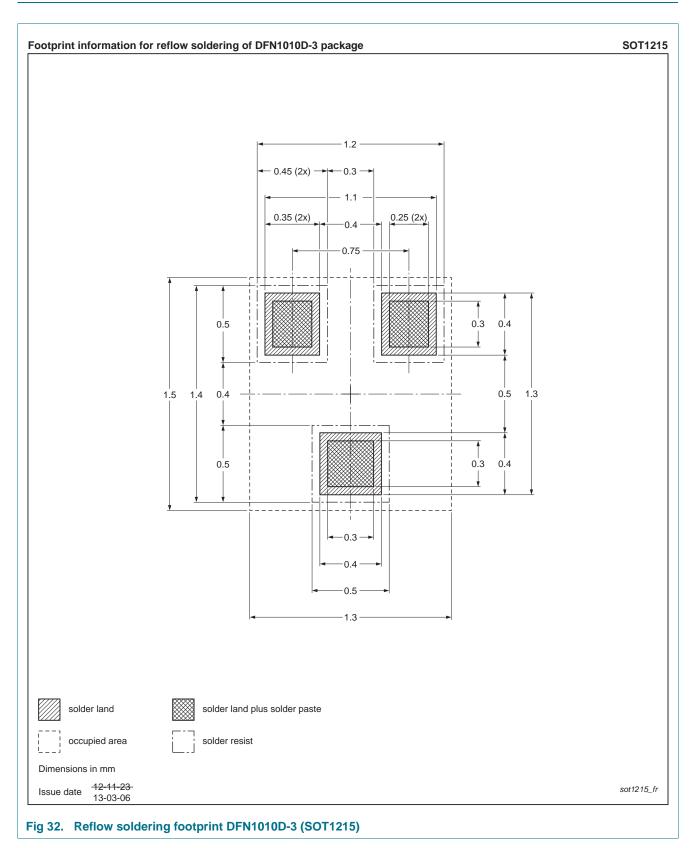
Table 9. Resistor test conditions

Type number	R1 (kΩ)	R2 (kΩ)	Test conditions				
			I _{I1}	I _{I2}	I ₁₃	I ₁₄	
PDTC143EQA	4.7	4.7	600 μΑ	700 μΑ	-600 μΑ	-700 μΑ	
PDTC114EQA	10	10	350 μΑ	450 μΑ	-350 μΑ	-450 μΑ	
PDTC124EQA	22	22	150 μΑ	230 μΑ	-150 μΑ	-230 μΑ	
PDTC144EQA	47	47	55 μΑ	105 μΑ	-55 μΑ	-105 μΑ	

9. Package outline



10. Soldering



PDTC143_114_124_144EQA_SER

PDTC143/114/124/144EQA series

50 V, 100 mA NPN resistor-equipped transistor

11. Revision history

Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PDTC143_114_124_144EQA _SER v.1	20151030	Product data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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PDTC143/114/124/144EQA series

50 V, 100 mA NPN resistor-equipped transistor

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